

### Voltage Detector with Adjustable Delay Time

#### **Features**

- Operate from VCC of 1.2V to 5.5V
- Capacitor-Adjustable Delay
- Active-High/-Low Output Options
- Open-Drain /Push-Pull Output Options
- Detect Voltage Threshold Accurate: 2.5% in full Temperature from -40  $^{\circ}$ C to +85  $^{\circ}$ C
- Low Supply Current (2 μA, Typ.)
- Ultra-Small 4-Pin UDFN Package or SOT23-5
   Package or SC70-4 package

## **Applications**

- Computers/Servers/Networking
- Medical Equipment
- Critical µP Monitoring
- Intelligent Instruments
- Set-Top Boxes/Portable Equipment

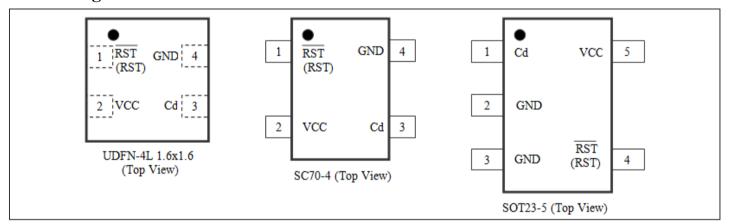
## **Description**

The PT7M6518-6550 is a family of small, low-power, voltage-monitoring circuits with adjustable delay time capability. PT7M65xx series features a highly accurate under voltage detector with hysteresis and an externally programmable time delay generator. This combination of features prevents erratic system reset operation.

PT7M65xx series provide external capacitor to adjust for set up delay time.

All series operate from a 1.2V to 5.5V supply voltage and are fully specified over the -40  $^{\circ}$ C to +85  $^{\circ}$ C operating temperature range. This family is available in ultra-small 4-pin UDFN (1.6mm x 1.6mm) and SC70-4 and SOT23-5 packages.

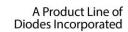
## **Pin Configuration**



**Pin Description** 

Name	Type	Description
RST	О	Active Low Reset Output: $\overline{RST}$ is asserted to LOW when $V_{CC}$ drops below voltage threshold $V_{TH.}$ value (PT7M65xxCL/NL). PT7M65xxCL output with push-pull. PT7M65xxNLoutput with open-drain which requires external pullup resistance.
RST	О	Active High Reset Output. RST is asserted High when $V_{CC}$ drops below voltage threshold $V_{TH}$ voltage (PT7M65xxCH). PT7M65xxCH output with push-pull.
GND	P	Ground.
V <sub>CC</sub>	P	<b>Supply Voltage.</b> Operation voltage from 1.2V to 5.5V. By pass 0.1uF ceramic capacitor to GND for noise decoupling.
Cd	I/O	Capacitor Delay. Adjustable. Connect an external capacitor from Cd pin to GND to set the Reset inactive delay time (timeout period) after VCC rise over voltage threshold $V_{TH+}$ . Do not short Cd pin to GND directly. The delay time equation as $t_{delay}$ =Cd( $\mu$ F)×4×10 <sup>6</sup> $\mu$ s +40 $\mu$ s.







**Table 1 Function comparison** 

Item						
	Part No.	Open-	Drain	Pus	sh-Pull	Threshold
		Active high	Active low	Active high	Active low	
1	PT7M65xxCL	-	-	-	√	
2	PT7M65xxCH	-	-	√	-	1.8V to 5.0V in 100mV increments
3	PT7M65xxNL	-	$\checkmark$	-	-	merements

## **Maximum Ratings**

Storage Temperature	-65°C to +150°C
Ambient Temperature with Power Applied.	-40°C to +85°C
Supply Voltage to Ground Potential (Vcc to	GND)0.3V to +6.0V
DC Input Voltage (All inputs except Vcc ar	ad GND)0.3V to V <sub>CC</sub> +0.3V
DC Output Current (All outputs)	20mA
Power Dissipation	320mW (Depend on package)

#### Note:

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

## **DC** Electrical Characteristics

 $(V_{CC} = 1.2V \text{ to } 5.5V, T_A = -40 \sim 85 \text{ C}, \text{ unless otherwise noted. Typical values are at } T_A = +25 \text{ C})$ 

Description		Sym.	Test Conditions	Min	Тур.	Max.	Unit	
Supply Voltage		V	T <sub>A</sub> = 0~70 ℃	1.0	-	5.5	V	
		$V_{CC}$	T <sub>A</sub> = -40~85 ℃	1.2	-	5.5		
Supply Current		Ţ	$V_{CC} = 3.6V$ . No load.	-	1.3	3.6	μΑ	
		$I_{CC}$	$V_{CC} = 5V$ . No load.	-	2.0	5.0	μΑ	
			$V_{CC} \ge 1.8V$ , $I_{source} = 1mA$	0.8×Vcc	-	-		
	Output high (push-pull)	$V_{OH}$	$V_{CC} \ge 2.5V$ , $I_{source} = 3mA$	0.8×Vcc	-	-	V	
Output	(push puh)		$V_{CC} \ge 4.5V$ , $I_{source} = 8mA$	0.8×Vcc	-	-		
Driving	Output low	$V_{OL}$	$V_{CC} \ge 1.2V$ , $I_{sink} = 1mA$	-	-	0.3	V	
	(open-drain or push-pull)		$V_{CC} \ge 2.5V$ , $I_{sink} = 4mA$	-	-	0.3		
			$V_{CC} \ge 4.5V$ , $I_{sink} = 9mA$	-	-	0.4		
Open-Drain Output Leakage Current		$I_{LKG}$	-	-	-	1	μΑ	
VCC Detect Voltage Threshold		V	+25°C	(V <sub>TH-</sub> ) ×0.985	$V_{\text{TH-}}$	(V <sub>TH-</sub> ) ×1.015		
		V <sub>TH-</sub>	-40°C~85°C	(V <sub>TH-</sub> ) ×0.975	$V_{TH-}$	(V <sub>TH-</sub> ) ×1.025	V	
		$V_{TH+}$	+25°C	(V <sub>TH+</sub> ) ×0.985	$V_{\text{TH+}}$	(V <sub>TH+</sub> ) ×1.015	•	
			-40°C~85°C	(V <sub>TH+</sub> ) ×0.975	$V_{TH+}$	(V <sub>TH+</sub> ) ×1.025	1	
Delay charge current		Icd	-	200	250	300	nA	
Delay voltage Threshold		Vtcd	Cdelay rising	0.95	1.00	1.05	V	
Cdelay pulldown Resistance		Rcdelay	-		200	500	Ω	

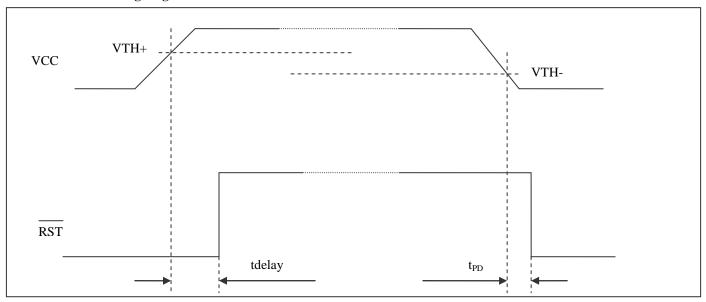
Note:  $V_{TH+} = 1.05 \times V_{TH+}$ .  $V_{TH-}$  is voltage threshold when Vcc falls from high to low.  $V_{TH+}$  is voltage threshold when Vcc rises from low to high.





## **AC Electrical Characteristics**

PT7M65xxNL Timing diagram



 $(V_{CC} = 1.2V \text{ to } 5.5V, T_A = -40 \sim 85 \text{ C}, \text{ unless otherwise noted. Typical values are at } T_A = +25 \text{ C})$ 

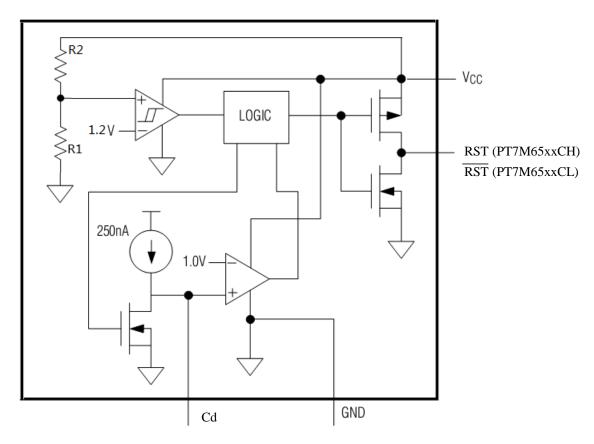
Sym.	Description	Test Conditions	Min.	Тур.	Max.	Unit
$t_{PD}$	Reset active Propagation Delay		-	50	-	μs
$t_{ m delay}$	Reset inactive delay time after VCC > V <sub>TH+</sub> (Reset Timeout Period).		-	$Cd(\mu F) \times 4 \times 10^6 + 40$	-	μs

## **Function Description**

PT7M65xx has adjustable reset output delay time function throw Cd pin with cap. Internal 250nA sourcing will charge the external cap throw Cd pin when VCC is rise above  $V_{TH+}$ , and reset output will disalert after Cd pin voltage is reaches 1V. This delay time is  $t_{delay}$ =Cd ( $\mu$ F) ×4×10<sup>6</sup>  $\mu$ s +40  $\mu$ s. For example, if Cd=1nF, the  $t_{delay}$ =0.001×4×10<sup>6</sup>  $\mu$ s +40  $\mu$ s=4040  $\mu$ s. Cd pin voltage will be discharged when reset output is assert ok at Vcc falls below Vth-, the discharge resistance is about 200 $\Omega$ .

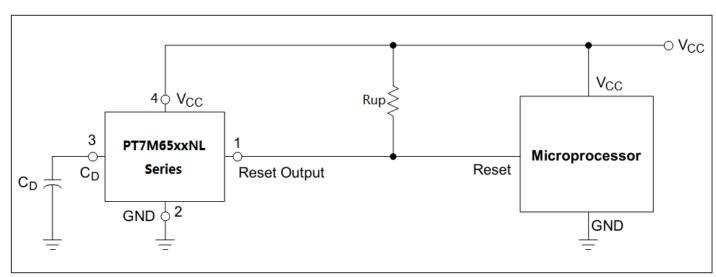


## **Block Diagram**



# **Typical Operation Circuit**

### PT7M65xxNL Application Example



Note: Capacitor-Adjustable Delay application.

Connect an external capacitor ( $C_{\text{Cd}}$ ) from Cd to GND delay period.

 $t_{delay}$ =Cd( $\mu f$ )×4×10<sup>6</sup> $\mu s$  +40 $\mu s$ 

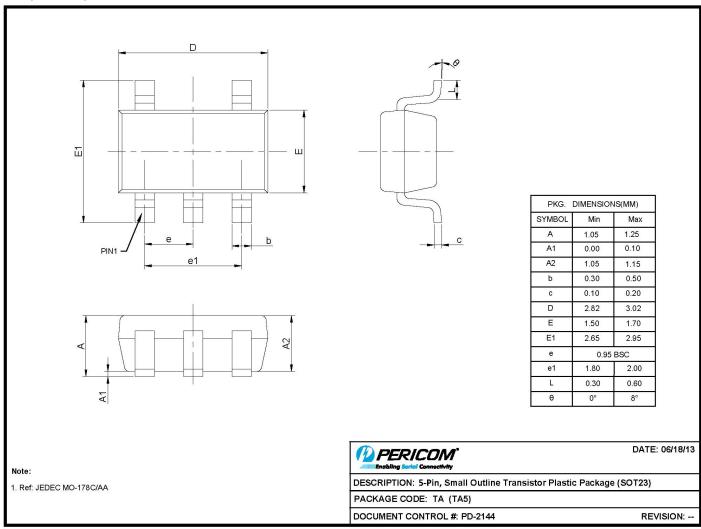
There is a fixed short delay (40µs, typ.) for the output deasserting when Vin falls below Vth.





## **Mechanical Information:**

### TA5 (SOT23-5)

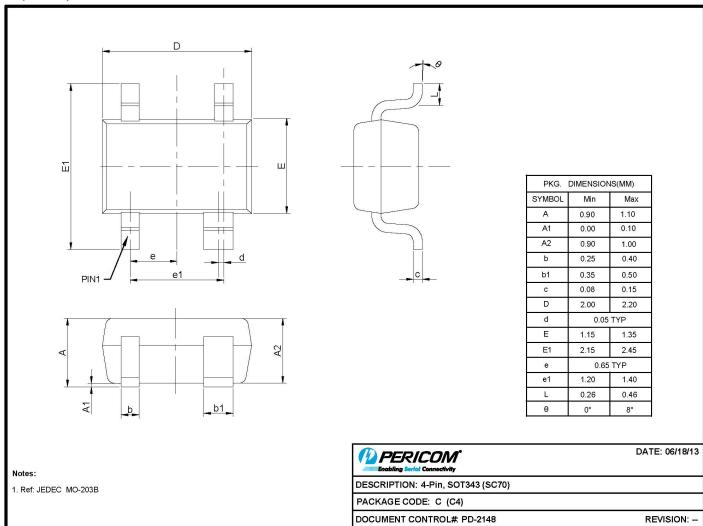


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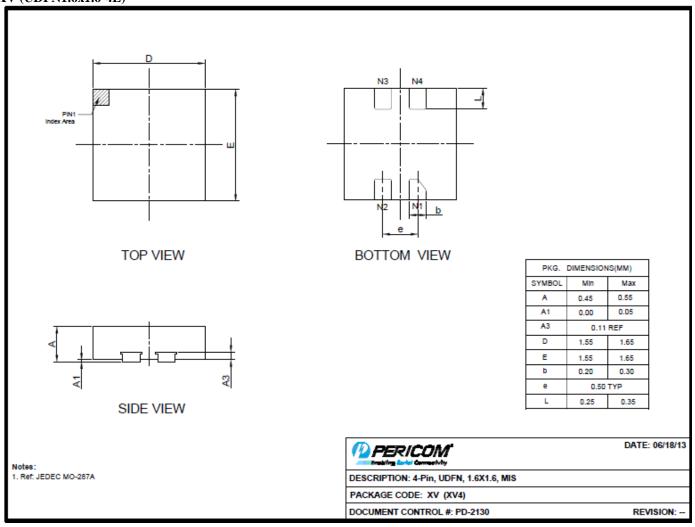
## C4 (SC70-4)



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#### XV (UDFN1.6x1.6-4L)



### For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/



# **Ordering Information**

Part Number	Package Code	Package
PT7M65xxCLTA5E	TA5	Lead free and Green SOT23-5
PT7M65xxCLC4E	C4	Lead free and Green SC70-4
PT7M65xxCLXVE	XV	Lead Free and Green DFN1.6X1.6-4L
PT7M65xxNLTA5E	TA5	Lead free and Green SOT23-5
PT7M65xxNLXVE	XV	Lead Free and Green DFN1.6X1.6-4L
PT7M65xxNLC4E	C4	Lead free and Green SC70-4
*PT7M65xxCHTA5E	TA5	Lead free and Green SOT23-5
*PT7M65xxCHXVE	XV	Lead Free and Green DFN1.6X1.6-4L
*PT7M65xxCHC4E	C4	Lead free and Green SC70-4

#### **Notes:**

- "xx" refer to voltage range, see below table 2.
- E = Pb-Free and Green
- Adding X Suffix= Tape/Reel
- Thermal characteristics can be found on the company web site at www.diodes.com/design/support/packaging/
- "\*" for CH part, please check the storage with related sales.

## Table 2 Suffix "xx" definition of PT7M65xx

Suffix xx	$V_{TH-}(V)$	Suffix xx	V <sub>TH-</sub> (V)	Suffix xx	$V_{TH-}(V)$	Suffix xx	V <sub>TH-</sub> (V)	Suffix xx	$V_{TH-}(V)$
18	1.8	25	2.5	32	3.2	39	3.9	46	4.6
19	1.9	26	2.6	33	3.3	40	4.0	47	4.7
20	2.0	27	2.7	34	3.4	41	4.1	48	4.8
21	2.1	28	2.8	35	3.5	42	4.2	49	4.9
22	2.2	29	2.9	36	3.6	43	4.3	50	5.0
23	2.3	30	3.0	37	3.7	44	4.4		
24	2.4	31	3.1	38	3.8	45	4.5		



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